S-8215AAX-K8T2U Datasheet

DiGi Electronics Part Number	S-8215AAX-K8T2U-DG
Manufacturer	ABLIC Inc.
Manufacturer Product Number	S-8215AAX-K8T2U
Description	LITHIUM-ION BATTERY PROTECTION I
Detailed Description	Battery Battery Protection IC Lithium Ion 8-TMSOP

https://www.DiGi-Electronics.com

Tel: +00 852-30501935

RFQ Email: Info@DiGi-Electronics.com

Purchase and inquiry

Manufacturer Product Number:	Manufacturer:
S-8215AAX-K8T2U	ABLIC Inc.
Series:	Product Status:
S-8215A	Active
Function:	Battery Chemistry:
Battery Protection	Lithium Ion
Number of Cells:	Fault Protection:
3 ~ 5	-
Interface:	Operating Temperature:
-	-40°C ~ 85°C (TA)
Mounting Type:	Package / Case:
Surface Mount	8-WSSOP, 8-MSOP (0.110", 2.80mm Width)
Supplier Device Package:	Base Product Number:
8-TMSOP	S-8215

Environmental & Export classification

RoHS Status:	Moisture Sensitivity Level (MSL):
ROHS3 Compliant	1 (Unlimited)
REACH Status:	ECCN:
REACH Unaffected	EAR99
HTSUS:	
8542.39.0001	

S-8215A Series

BATTERY PROTECTION IC FOR 3-SERIAL TO 5-SERIAL CELL PACK (SECONDARY PROTECTION)

www.ablic.com

Rev.2.6_00

The S-8215A Series is used for secondary protection of lithium-ion rechargeable batteries, and incorporates high-accuracy voltage detection circuits and delay circuits.
Short-circuiting between cells makes it possible for serial connection of three cells to five cells.

■ Features

- High-accuracy voltage detection circuit for each cell
  - Overcharge detection voltage n (n = 1 to 5)
    - 3.600 V to 4.700 V (50 mV step)
    - Accuracy ±25 mV (Ta = +25°C)
    - Accuracy ±30 mV (Ta = –5°C to +55°C)
  - Overcharge hysteresis voltage n (n = 1 to 5)
    - 0.0 mV to –550 mV (50 mV step)
    - –300 mV to –550 mV Accuracy ±20%
    - –100 mV to –250 mV Accuracy ±50 mV
    - 0.0 mV to –50 mV Accuracy ±25 mV
- Delay times for overcharge detection can be set by an internal circuit only (External capacitors are unnecessary).
- Output form is selectable: CMOS output, Nch open-drain output, Pch open-drain output
- Output logic is selectable: Active "H", active "L"
- High-withstand voltage: Absolute maximum rating 28 V
- Wide operation voltage range: 3.6 V to 26 V
- Wide operation temperature range: Ta = –40°C to +85°C
- Low current consumption
  - At V_{CUn} – 1.0 V for each cell: 3.0 µA max. (Ta = +25°C)
  - At 2.3 V for each cell: 1.7 µA max. (Ta = +25°C)
- Lead-free (Sn 100%), halogen-free

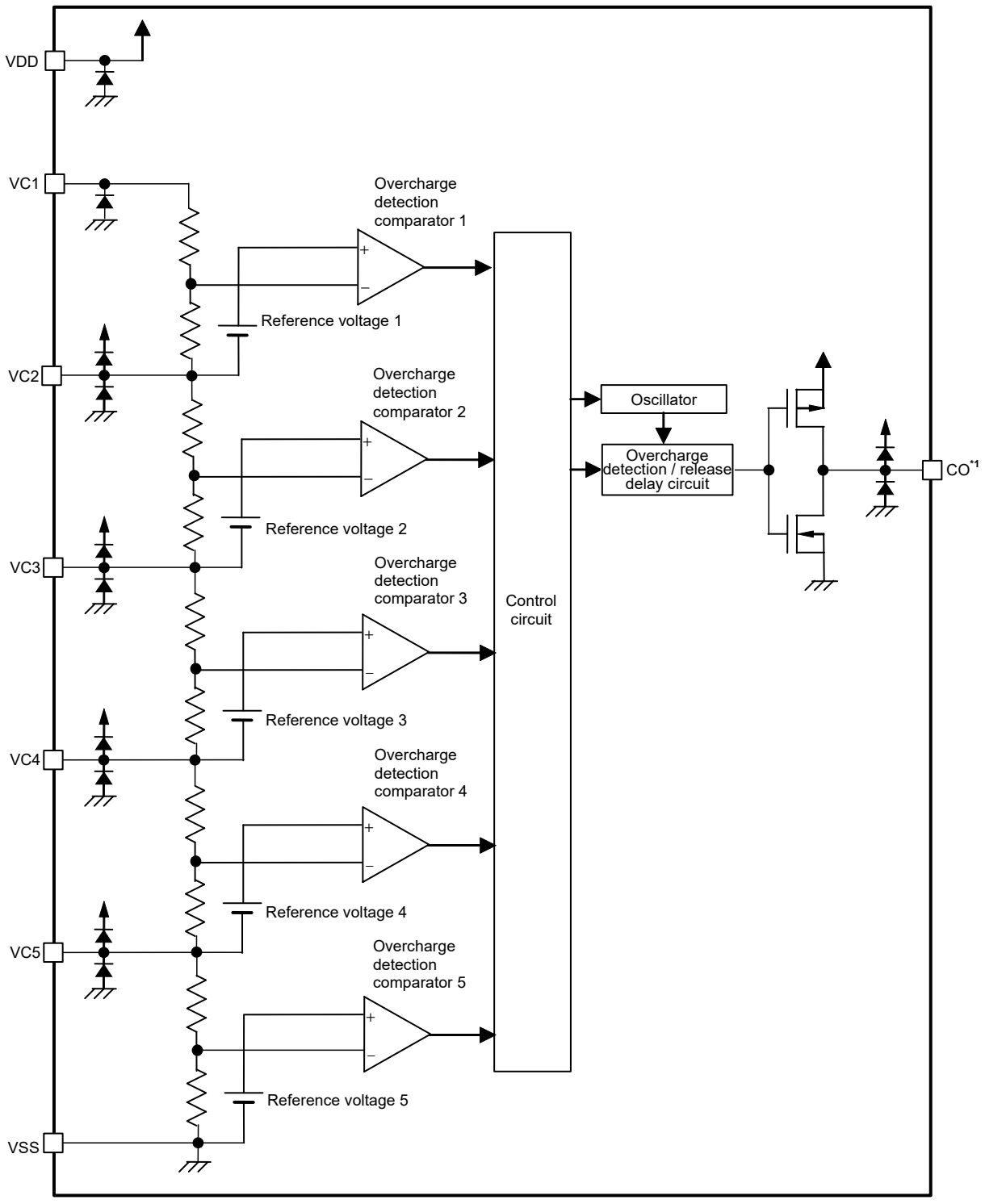
■ Application

- Lithium-ion rechargeable battery pack (for secondary protection)

■ Packages

- TMSOP-8
- SNT-8A

■ Block Diagram



***1.** The CO pin is connected only to Nch transistor in the case of Nch open-drain output.
The CO pin is connected only to Pch transistor in the case of Pch open-drain output.

Remark The diodes in the figure are parasitic diodes.

Figure 1

■ Product Name Structure

1. Product name

S-8215A xx - xxxx U

- Environmental code
  - U: Lead-free (Sn 100%), halogen-free
- Package abbreviation and IC packing specifications*1
  - K8T2: TMSOP-8, Tape
  - I8T1: SNT-8A, Tape
- Serial code*2
  - Sequentially set from AA to AZ

***1.** Refer to the tape drawing.
***2.** Refer to "**3. Product name list**".

2. Packages

Table 1 Package Drawing Codes

Package Name	Dimension	Tape	Reel	Land
TMSOP-8	FM008-A-P-SD	FM008-A-C-SD	FM008-A-R-SD	–
SNT-8A	PH008-A-P-SD	PH008-A-C-SD	PH008-A-R-SD	PH008-A-L-SD

3. Product name list

3. 1 TMSOP-8

Table 2

Product Name	Overcharge Detection Voltage [V_{CU}]	Overcharge Hysteresis Voltage [V_{HC}]	Overcharge Detection Delay Time [t_{CU}]	Output Form	Output Logic
S-8215AAA-K8T2U	4.300 V	−0.300 V	4.0 s	CMOS output	Active "H"
S-8215AAB-K8T2U	4.275 V	−0.050 V	2.0 s	Nch open-drain output	Active "L"
S-8215AAC-K8T2U	4.150 V	−0.250 V	1.0 s	CMOS output	Active "H"
S-8215AAD-K8T2U	4.350 V	−0.250 V	2.0 s	CMOS output	Active "H"
S-8215AAE-K8T2U	4.325 V	−0.050 V	1.0 s	Nch open-drain output	Active "L"
S-8215AAF-K8T2U	4.220 V	−0.100 V	1.0 s	CMOS output	Active "H"
S-8215AAH-K8T2U	4.325 V	−0.300 V	1.0 s	Nch open-drain output	Active "L"
S-8215AAI-K8T2U	4.250 V	−0.250 V	1.0 s	CMOS output	Active "H"
S-8215AAJ-K8T2U	4.400 V	−0.100 V	2.0 s	CMOS output	Active "H"
S-8215AAK-K8T2U	4.150 V	−0.050 V	2.0 s	Nch open-drain output	Active "L"
S-8215AAL-K8T2U	4.150 V	−0.500 V	2.0 s	Nch open-drain output	Active "L"
S-8215AAM-K8T2U	4.150 V	−0.050 V	2.0 s	CMOS output	Active "L"
S-8215AAN-K8T2U	4.150 V	−0.500 V	2.0 s	CMOS output	Active "L"
S-8215AAO-K8T2U	4.350 V	−0.250 V	4.0 s	CMOS output	Active "H"
S-8215AAP-K8T2U	4.275 V	−0.500 V	1.0 s	CMOS output	Active "H"
S-8215AAQ-K8T2U	4.275 V	−0.050 V	1.0 s	CMOS output	Active "H"
S-8215AAR-K8T2U	4.500 V	−0.100 V	4.0 s	CMOS output	Active "H"
S-8215AAS-K8T2U	4.275 V	−0.200 V	2.0 s	CMOS output	Active "L"
S-8215AAT-K8T2U	4.275 V	−0.050 V	2.0 s	CMOS output	Active "L"
S-8215AAU-K8T2U	3.750 V	−0.100 V	1.0 s	CMOS output	Active "H"
S-8215AAV-K8T2U	4.300 V	−0.300 V	1.0 s	CMOS output	Active "H"
S-8215AAW-K8T2U	4.325 V	−0.050 V	8.0 s	CMOS output	Active "H"
S-8215AAX-K8T2U	4.325 V	−0.300 V	8.0 s	CMOS output	Active "H"
S-8215AAY-K8T2U	4.325 V	−0.400 V	8.0 s	CMOS output	Active "H"
S-8215AAZ-K8T2U	4.275 V	−0.050 V	1.0 s	Nch open-drain output	Active "L"

Remark Please contact our sales office for products other than the above.

3. 2 SNT-8A

Table 3

Product Name	Overcharge Detection Voltage [V_{CU}]	Overcharge Hysteresis Voltage [V_{HC}]	Overcharge Detection Delay Time [t_{CU}]	Output Form	Output Logic
S-8215AAA-I8T1U	4.300 V	−0.300 V	4.0 s	CMOS output	Active "H"
S-8215AAG-I8T1U	4.220 V	−0.050 V	1.0 s	CMOS output	Active "H"
S-8215AAV-I8T1U	4.300 V	−0.300 V	1.0 s	CMOS output	Active "H"

Remark Please contact our sales office for products other than the above.

■ Pin Configurations

1. TMSOP-8

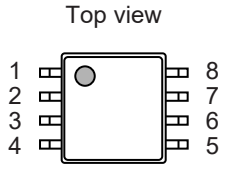


Figure 2

Table 4

Pin No.	Symbol	Description
1	VDD	Input pin for positive power supply
2	VC1	Positive voltage connection pin of battery 1
3	VC2	Negative voltage connection pin of battery 1 Positive voltage connection pin of battery 2
4	VC3	Negative voltage connection pin of battery 2 Positive voltage connection pin of battery 3
5	VC4	Negative voltage connection pin of battery 3 Positive voltage connection pin of battery 4
6	VC5	Negative voltage connection pin of battery 4 Positive voltage connection pin of battery 5
7	VSS	Input pin for negative power supply Negative voltage connection pin of battery 5
8	CO	FET gate connection pin for charge control

2. SNT-8A

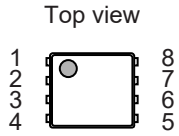


Figure 3

Table 5

Pin No.	Symbol	Description
1	VDD	Input pin for positive power supply
2	VC1	Positive voltage connection pin of battery 1
3	VC2	Negative voltage connection pin of battery 1 Positive voltage connection pin of battery 2
4	VC3	Negative voltage connection pin of battery 2 Positive voltage connection pin of battery 3
5	VC4	Negative voltage connection pin of battery 3 Positive voltage connection pin of battery 4
6	VC5	Negative voltage connection pin of battery 4 Positive voltage connection pin of battery 5
7	VSS	Input pin for negative power supply Negative voltage connection pin of battery 5
8	CO	FET gate connection pin for charge control

■ Absolute Maximum Ratings

Table 6

(Ta = +25°C unless otherwise specified)

Item		Symbol	Applied Pin	Absolute Maximum Rating	Unit
Input voltage between VDD pin and VSS pin		V_{DS}	VDD	V_{SS} – 0.3 to V_{SS} + 28	V
Input pin voltage		V_{IN}	VC1, VC2, VC3, VC4, VC5	V_{SS} – 0.3 to V_{DD} + 0.3	V
CO pin output voltage	CMOS output product	V_{CO}	CO	V_{SS} – 0.3 to V_{DD} + 0.3	V
	Nch open-drain output product			V_{SS} – 0.3 to V_{SS} + 28	V
	Pch open-drain output product			V_{DD} – 28 to V_{DD} + 0.3	V
Power dissipation	TMSOP-8	P_D	–	650*1	mW
	SNT-8A			450*1	mW
Operation ambient temperature		T_{opr}	–	–40 to +85	°C
Storage temperature		T_{stg}	–	–40 to +125	°C

***1.** When mounted on board

[Mounted board]

(1) Board size: 114.3 mm × 76.2 mm × t1.6 mm

(2) Name: JEDEC STANDARD51-7

Caution The absolute maximum ratings are rated values exceeding which the product could suffer physical damage. These values must therefore not be exceeded under any conditions.

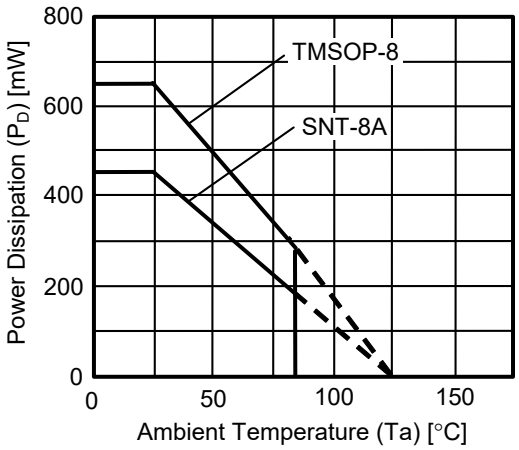


Figure 4 Power Dissipation of Package (When Mounted on Board)

■ Electrical Characteristics

Table 7

(Ta = +25°C unless otherwise specified)

Item	Symbol	Condition	Min.	Typ.	Max.	Unit	Test Circuit
Detection Voltage							
Overcharge detection voltage n (n = 1, 2, 3, 4, 5)	V_{CUn}	–	V_{CU} – 0.025	V_{CU}	V_{CU} + 0.025	V	1
		Ta = –5°C to +55°C*1	V_{CU} – 0.030	V_{CU}	V_{CU} + 0.030	V	1
Overcharge hysteresis voltage n (n = 1, 2, 3, 4, 5)	V_{HCn}	–550 mV ≤ V_{HC} ≤ –300 mV	$V_{HC} \times 0.8$	V_{HC}	$V_{HC} \times 1.2$	V	1
		–250 mV ≤ V_{HC} ≤ –100 mV	V_{HC} – 0.050	V_{HC}	V_{HC} + 0.050	V	1
		V_{HC} = –50 mV, 0 mV	V_{HC} – 0.025	V_{HC}	V_{HC} + 0.025	V	1
Input Voltage							
Operation voltage between VDD pin and VSS pin	V_{DSOP}	–	3.6	–	26	V	–
Input Current							
Current consumption during operation	I_{OPE}	V1 = V2 = V3 = V4 = V5 = V_{CU} – 1.0 V	–	1.6	3.0	µA	3
Current consumption during overdischarge	I_{OPED}	V1 = V2 = V3 = V4 = V5 = 2.3 V	–	0.8	1.7	µA	3
VC1 pin current	I_{VC1}	V1 = V2 = V3 = V4 = V5 = V_{CU} – 1.0 V	–	0.2	0.4	µA	4
VCn pin current (n = 2, 3, 4, 5)	I_{VCn}	V1 = V2 = V3 = V4 = V5 = V_{CU} – 1.0 V	–0.3	0	0.3	µA	4
Output Current (CMOS Output Product)							
CO pin sink current	I_{COL}	–	0.4	–	–	mA	5
CO pin source current	I_{COH}	–	20	–	–	µA	5
Output Current (Nch Open-drain Output Product)							
CO pin sink current	I_{COL}	–	0.4	–	–	mA	5
CO pin leakage current "L"	I_{COLL}	–	–	–	0.1	µA	5
Output Current (Pch Open-drain Output Product)							
CO pin source current	I_{COH}	–	20	–	–	µA	5
CO pin leakage current "H"	I_{COLH}	–	–	–	0.1	µA	5
Delay Time							
Overcharge detection delay time	t_{CU}	–	$t_{CU} \times 0.8$	t_{CU}	$t_{CU} \times 1.2$	s	1
Overcharge timer reset delay time	t_{TR}	–	6	12	20	ms	1
Transition time to test mode	t_{TST}	–	–	–	80	ms	2

***1.** Since products are not screened at high and low temperature, the specification for this temperature range is guaranteed by design, not tested in production.

■ Test Circuits

1. Overcharge detection voltage, overcharge hysteresis voltage (Test circuit 1)

1. 1 Overcharge detection voltage n (V_{CUn})

Set V1 = V2 = V3 = V4 = V5 = V_{CU} – 0.05 V. The overcharge detection voltage 1 (V_{CU1}) is the V1 voltage when the CO pin's output changes after the voltage of V1 has been gradually increased.
Overcharge detection voltage (V_{CUn}) (n = 2 to 5) can be determined in the same way as when n = 1.

1. 2 Overcharge hysteresis voltage n (V_{HCn})

Set V1 = V_{CU} + 0.05 V, V2 = V3 = V4 = V5 = 2.5 V. The overcharge hysteresis voltage 1 (V_{HC1}) is the difference between V1 voltage and V_{CU1} when the CO pin's output changes after the V1 voltage has been gradually decreased.
Overcharge hysteresis voltage (V_{HCn}) (n = 2 to 5) can be determined in the same way as when n = 1.

2. Output current (Test circuit 5)

2. 1 Output current of CMOS output product

Set SW1 and SW2 to OFF.

2. 1. 1 Active "H"

(1) CO pin source current (I_{COH})
Set SW1 to ON after setting V1 = 5.5 V, V2 to V5 = 3.0 V, V6 = 0.5 V. I1 is the CO pin source current (I_{COH}) at that time.

(2) CO pin sink current (I_{COL})
Set SW2 to ON after setting V1 to V5 = 3.5 V, V7 = 0.5 V. I2 is the CO pin sink current (I_{COL}) at that time.

2. 1. 2 Active "L"

(1) CO pin source current (I_{COH})
Set SW1 to ON after setting V1 to V5 = 3.5 V, V6 = 0.5 V. I1 is the CO pin source current (I_{COH}) at that time.

(2) CO pin sink current (I_{COL})
Set SW2 to ON after setting V1 = 5.5 V, V2 to V5 = 3.0 V, V7 = 0.5 V. I2 is the CO pin sink current (I_{COL}) at that time.

2. 2 Output current of Nch open-drain output product

Set SW1 and SW2 to OFF.

2. 2. 1 Active "H"

(1) CO pin leakage current "L" (I_{COLL})
Set SW2 to ON after setting V1 = 5.5 V, V2 to V5 = 3.0 V, V7 = 17.5 V. I2 is the CO pin leakage current "L" (I_{COLL}) at that time.

(2) CO pin sink current (I_{COL})
Set V1 to V5 = 3.5 V, V7 = 0.5 V. I2 is the CO pin sink current (I_{COL}) at that time.

2. 2. 2 Active "L"

(1) CO pin leakage current "L" (I_{COLL})
Set SW2 to ON after setting V1 to V5 = 3.5 V, V7 = 17.5 V. I2 is the CO pin leakage current "L" (I_{COLL}) at that time.

(2) CO pin sink current (I_{COL})
Set V1 = 5.5 V, V2 to V5 = 3.0 V, V7 = 0.5 V. I2 is the CO pin sink current (I_{COL}) at that time.

2. 3 Output current of Pch open-drain output product

Set SW1 and SW2 to OFF.

2. 3. 1 Active "H"

(1) CO pin source current (I_{COH})
Set SW1 to ON after setting V1 = 5.5 V, V2 to V5 = 3.0 V, V6 = 0.5 V. I1 is the CO pin source current (I_{COH}) at that time.

(2) CO pin leakage current "H" (I_{COLH})
Set V1 to V5 = 3.5 V, V6 = 17.5 V. I1 is the CO pin leakage current "H" (I_{COLH}) at that time.

2. 3. 2 Active "L"

(1) CO pin source current (I_{COH})
Set SW1 to ON after setting V1 to V5 = 3.5 V, V6 = 0.5 V. I1 is the CO pin source current (I_{COH}) at that time.

(2) CO pin leakage current "H" (I_{COLH})
Set V1 = 5.5 V, V2 to V5 = 3.0 V, V6 = 17.5 V. I1 is the CO pin leakage current "H" (I_{COLH}) at that time.

3. Overcharge detection delay time (t_{CU})

(Test circuit 1)

Increase V1 up to 5.0 V after setting V1 = V2 = V3 = V4 = V5 = 3.5 V. The overcharge detection delay time (t_{CU}) is the time period until the CO pin output changes.

4. Overcharge timer reset delay time (t_{TR})

(Test circuit 1)

Increase V1 up to 5.0 V (first rise), and decrease V1 down to 3.5 V within t_{CU} after setting V1 = V2 = V3 = V4 = V5 = 3.5 V. After that, increase V1 up to 5.0 V again (second rise), and detect the time period till the CO pin output changes. When the period from when V1 has fallen to the second rise is short, CO pin output changes after t_{CU} has elapsed since the first rise. If the period is gradually made longer, CO pin output changes after t_{CU} has elapsed since the second rise. The overcharge timer reset delay time (t_{TR}) is the period from V1 fall till the second rise at that time.

5. Transition time to test mode (t_{TST})

(Test circuit 2)

Increase V6 up to 5.0 V, and decrease V6 again to 0 V after setting V1 = V2 = V3 = V4 = V5 = 3.5 V, and V6 = 0 V.
When the period from when V6 was raised to when it has fallen is short, if an overcharge detection operation is performed subsequently, the delay time is t_{CU}. However, when the period from when V6 is raised to when it has fallen is gradually made longer, the delay time during the subsequent overcharge detection operation is shorter than t_{CU}. The transition time to test mode (t_{TST}) is the period from when V6 was raised to when it has fallen at that time.

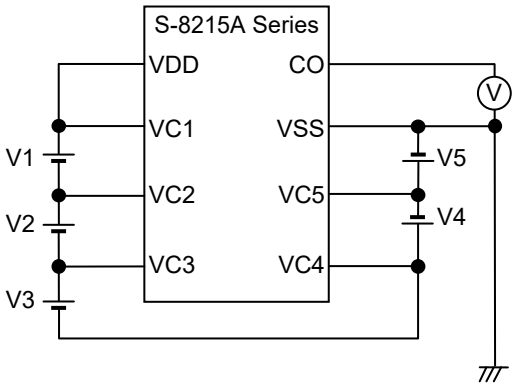


Figure 5 Test Circuit 1

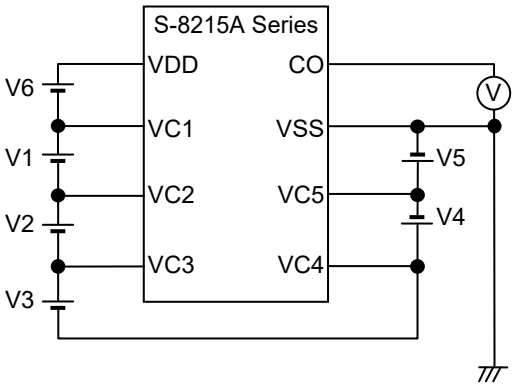


Figure 6 Test Circuit 2

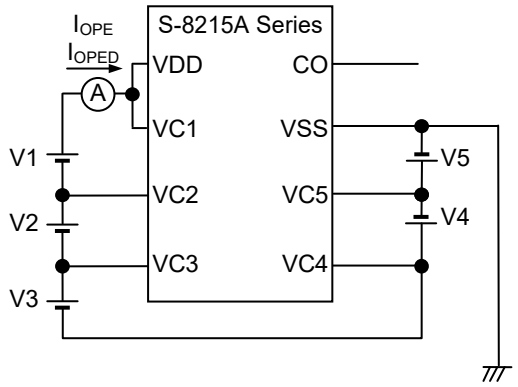


Figure 7 Test Circuit 3

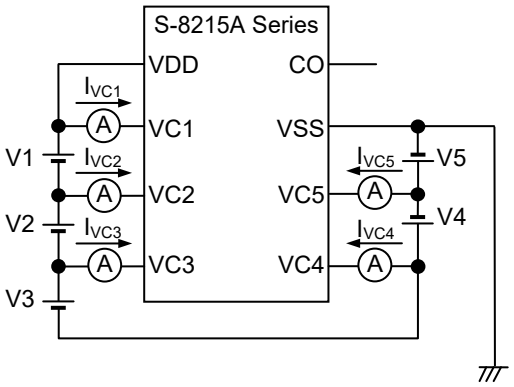


Figure 8 Test Circuit 4

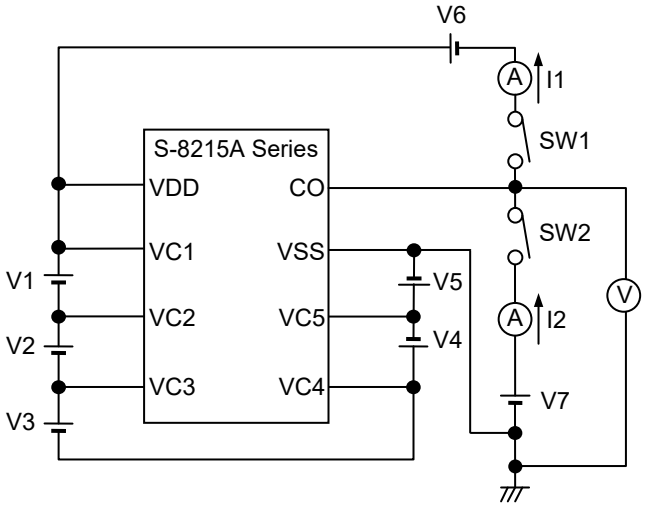


Figure 9 Test Circuit 5

■ Operation

Remark Refer to **"■ Battery Protection IC Connection Examples".**

1. Normal status

If the voltage of each of the batteries is lower than "the overcharge detection voltage n (V_{CUn}) + the overcharge hysteresis voltage n (V_{HCn})", the CO pin output changes to "L" (Active "H") or "H" (Active L"). This is called normal status.

2. Overcharge status

When the voltage of one of the batteries exceeds V_{CUn} during charging under normal status and the status is retained for the overcharge detection delay time (t_{CU}) or longer, the CO pin output changes. This is called overcharge status. Connecting FET to the CO pin provides charge control and a second protection.
If the voltage of each of the batteries is lower than $V_{CUn} + V_{HCn}$ and the status is retained for 2.0 ms typ. or longer, the S-8215A Series returns to normal status.

3. Overcharge timer reset function

When an overcharge release noise that forces the voltage of one of the batteries temporarily below V_{CUn} is input during t_{CU} from when V_{CUn} is exceeded to when charging is stopped, t_{CU} is continuously counted if the time the overcharge release noise persists is shorter than the overcharge timer reset delay time (t_{TR}). Under the same conditions, if the time the overcharge release noise persists is t_{TR} or longer, counting of t_{CU} is reset once. After that, when V_{CUn} has been exceeded, counting t_{CU} resumes.

4. Test mode

The overcharge detection delay time (t_{CU}) can be shortened by entering the test mode.
The test mode can be set by retaining the VDD pin voltage 5.0 V or more higher than the VC1 pin voltage for the transition time to test mode (t_{TST}) or longer. The status is retained by the internal latch and the test mode is retained even if the VDD pin voltage is decreased to the same voltage as that of the VC1 pin voltage.
After that, the latch for retaining the test mode is reset and the S-8215A Series exits from test mode under the overcharge status.

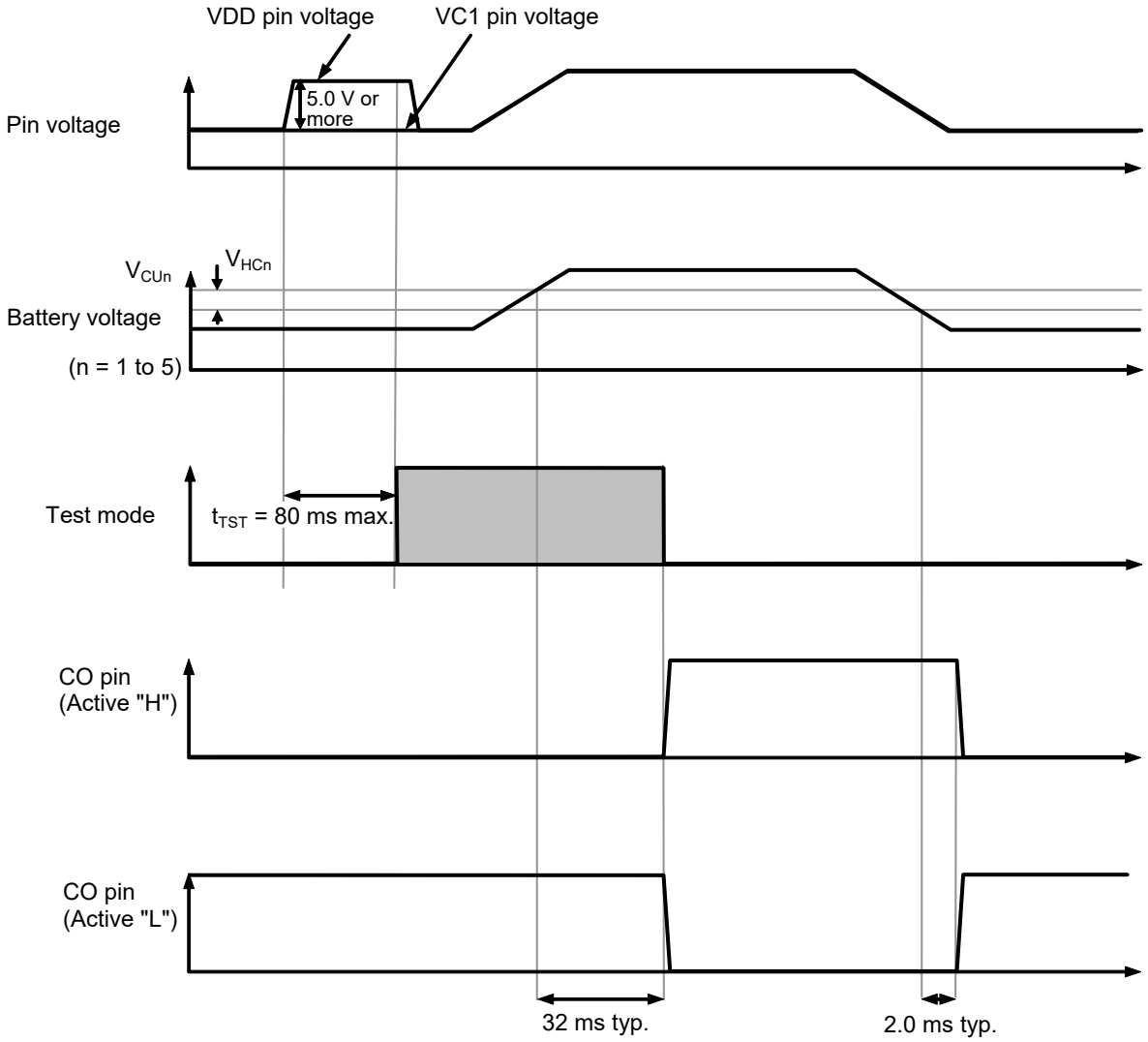


Figure 10

Caution
1. **When the VDD pin voltage is decreased to lower than the UVLO voltage of 2 V typ., the S-8215A Series exits from test mode.**
2. **Set the test mode when no batteries are overcharged.**
3. **The overcharge timer reset delay time (t_{TR}) is not shortened in the test mode.**

■ Timing Charts

1. Overcharge detection operation

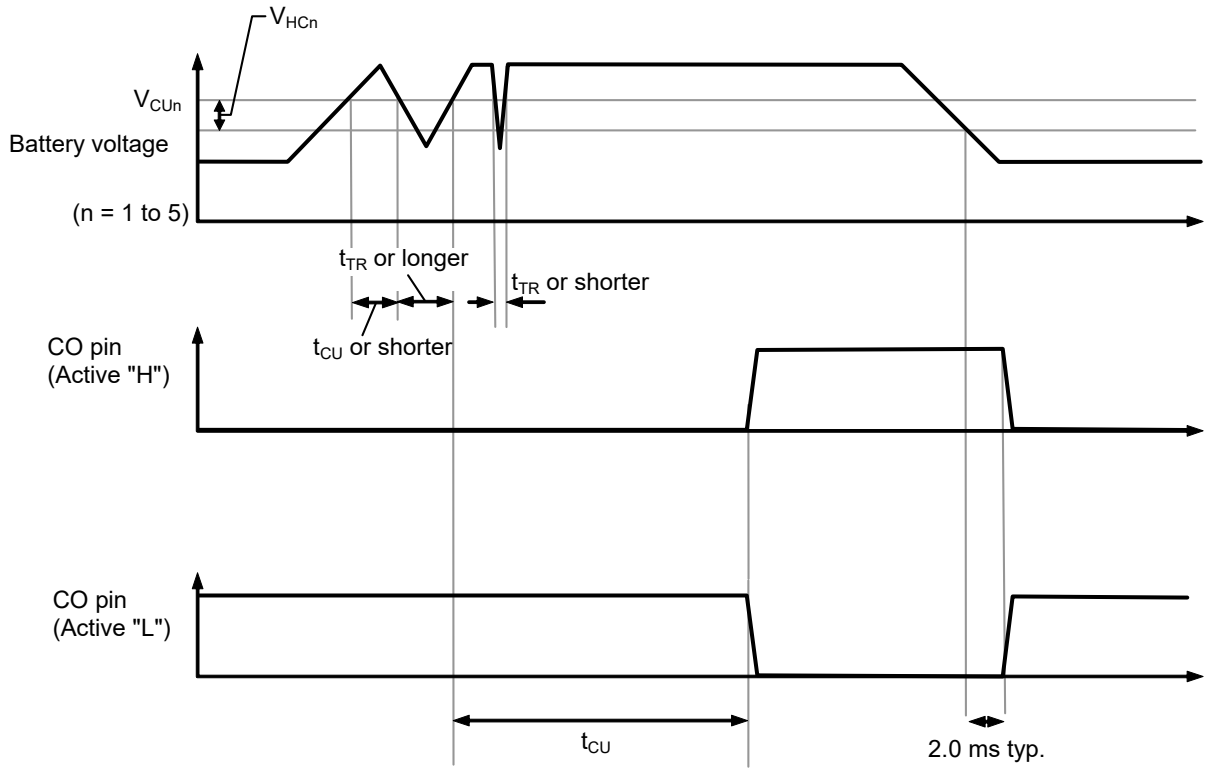


Figure 11

2. Overcharge timer reset operation

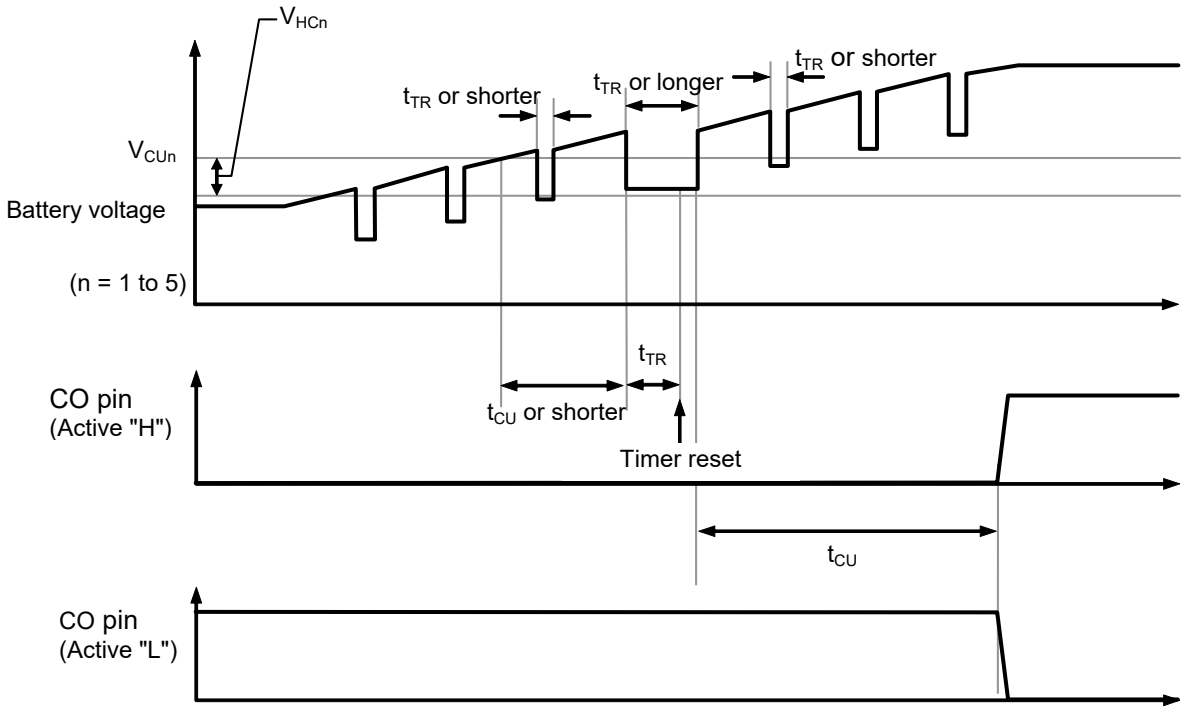


Figure 12

■ Battery Protection IC Connection Examples

1. 5-serial cell

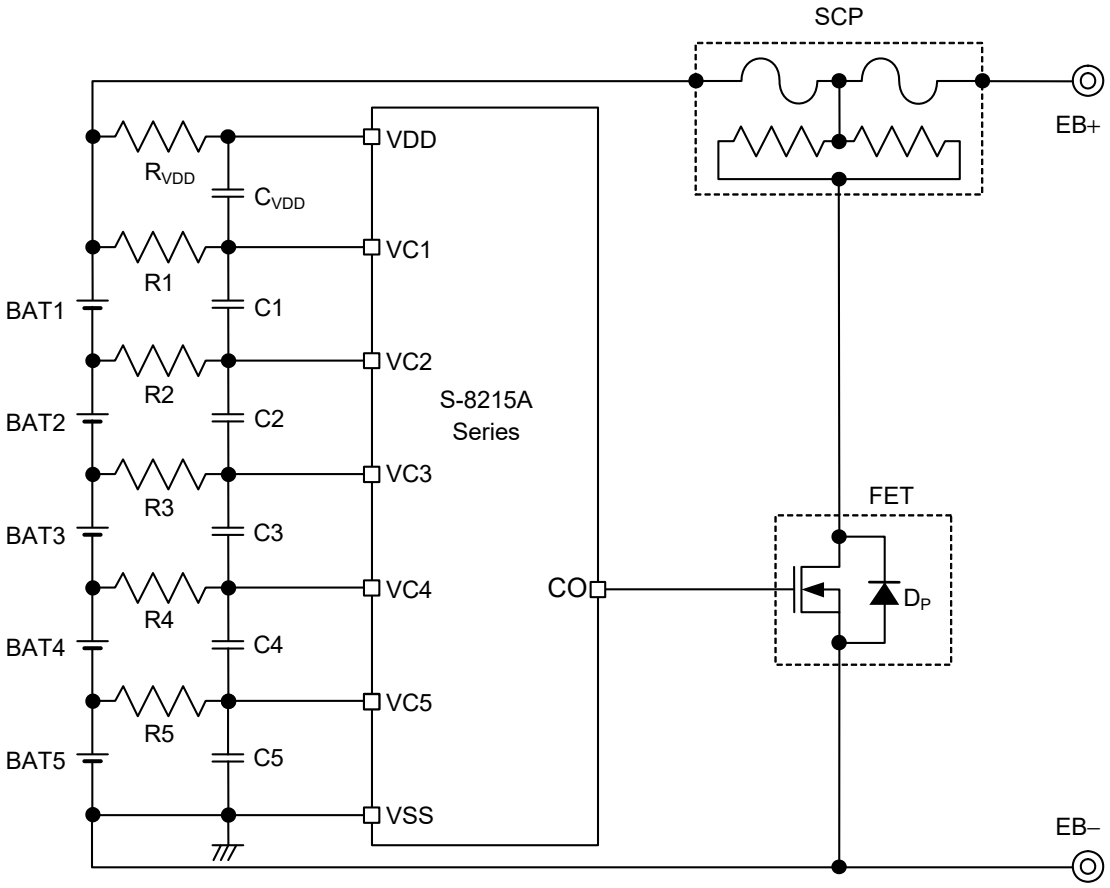


Figure 13

Table 8 Constants for External Components

No.	Part	Min.	Typ.	Max.	Unit
1	R1 to R5	0.5	1	10	kΩ
2	C1 to C5, C_{VDD}	0.01	0.1	1	μF
3	R_{VDD}	50	100	500	Ω

Caution
1. **The above constants are subject to change without prior notice.**
2. **It has not been confirmed whether the operation is normal or not in circuits other than the above example of connection. In addition, the example of connection shown above and the constants will not guarantee successful operation. Perform thorough evaluation using the actual application to set the constants.**
3. **R1 to R5 should be the same constant. C1 to C5 and C_{VDD} should be the same constant.**
4. **Set R_{VDD}, C1 to C5, and C_{VDD} so that the condition (R_{VDD}) × (C1 to C5, C_{VDD}) ≥ 5×10^{-6} is satisfied.**
5. **Set R1 to R5, C1 to C5, and C_{VDD} so that the condition (R1 to R5) × (C1 to C5, C_{VDD}) ≥ 1×10^{-4} is satisfied.**
6. **Since the CO pin may become detection status transiently when the battery is being connected, connect the positive terminal of BAT1 last in order to prevent the three terminal protection fuse from cutoff.**

2. 4-serial cell

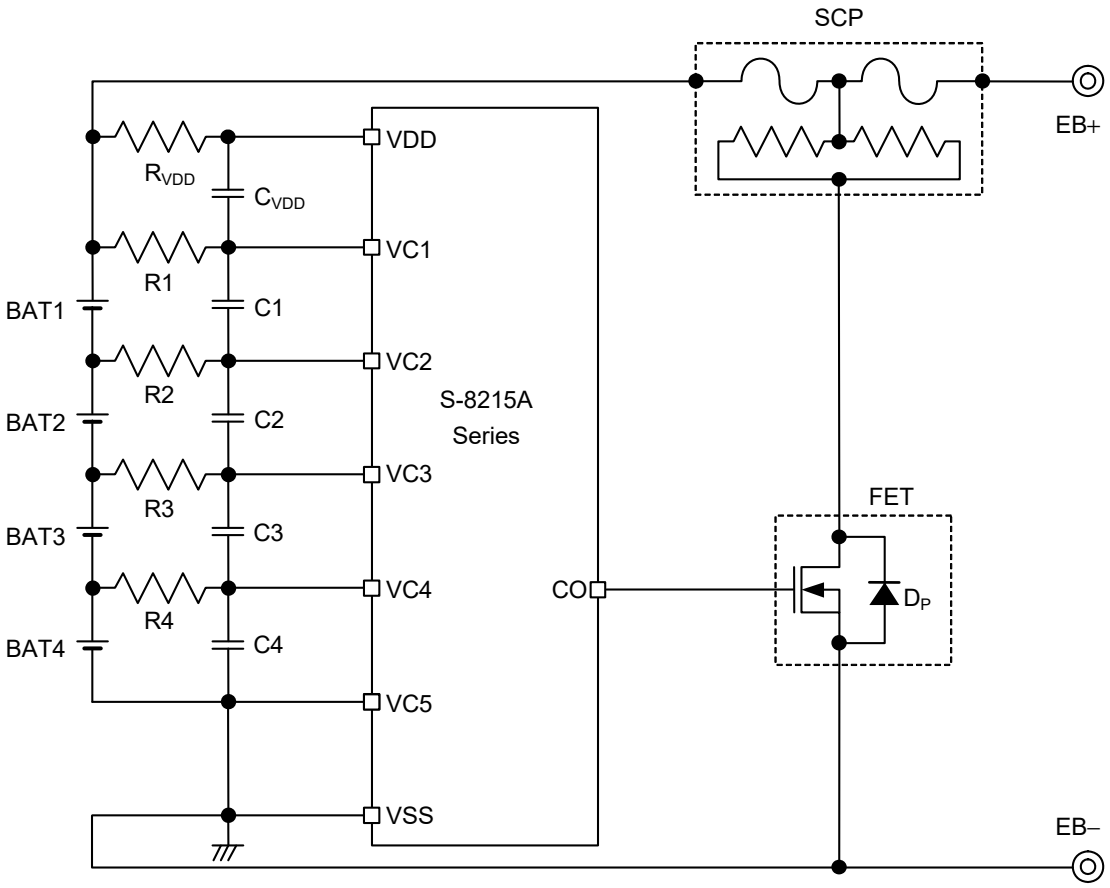


Figure 14

Table 9 Constants for External Components

No.	Part	Min.	Typ.	Max.	Unit
1	R1 to R4	0.5	1	10	kΩ
2	C1 to C4, C_{VDD}	0.01	0.1	1	μF
3	R_{VDD}	50	100	500	Ω

Caution
1. **The above constants are subject to change without prior notice.**
2. **It has not been confirmed whether the operation is normal or not in circuits other than the above example of connection. In addition, the example of connection shown above and the constants will not guarantee successful operation. Perform thorough evaluation using the actual application to set the constants.**
3. **R1 to R4 should be the same constant. C1 to C4 and C_{VDD} should be the same constant.**
4. **Set R_{VDD}, C1 to C4, and C_{VDD} so that the condition (R_{VDD}) × (C1 to C4, C_{VDD}) ≥ 5×10^{-6} is satisfied.**
5. **Set R1 to R4, C1 to C4, and C_{VDD} so that the condition (R1 to R4) × (C1 to C4, C_{VDD}) ≥ 1×10^{-4} is satisfied.**
6. **Since the CO pin may become detection status transiently when the battery is being connected, connect the positive terminal of BAT1 last in order to prevent the three terminal protection fuse from cutoff.**

3. 3-serial cell

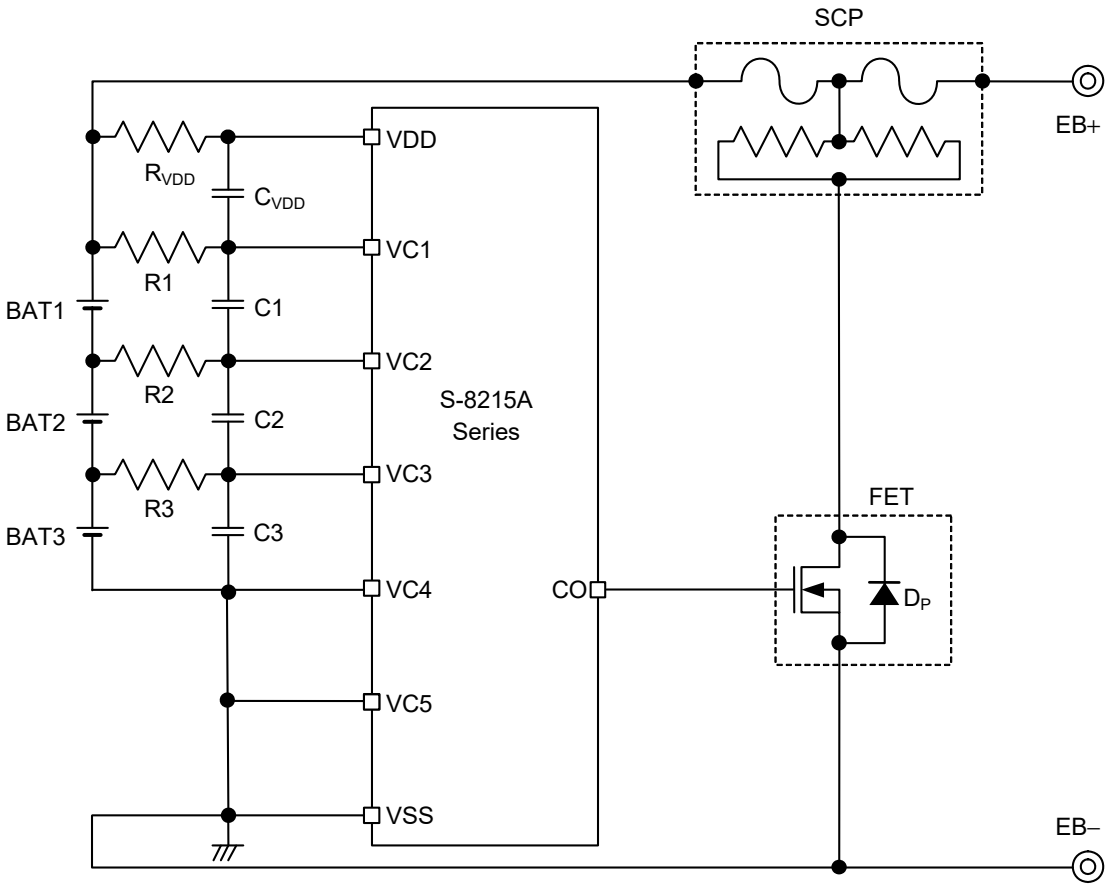


Figure 15

Table 10 Constants for External Components

No.	Part	Min.	Typ.	Max.	Unit
1	R1 to R3	0.5	1	10	kΩ
2	C1 to C3, C_{VDD}	0.01	0.1	1	μF
3	R_{VDD}	50	100	500	Ω

Caution
1. **The above constants are subject to change without prior notice.**
2. **It has not been confirmed whether the operation is normal or not in circuits other than the above example of connection. In addition, the example of connection shown above and the constants will not guarantee successful operation. Perform thorough evaluation using the actual application to set the constants.**
3. **R1 to R3 should be the same constant. C1 to C3 and C_{VDD} should be the same constant.**
4. **Set R_{VDD}, C1 to C3, and C_{VDD} so that the condition (R_{VDD}) × (C1 to C3, C_{VDD}) ≥ 5×10^{-6} is satisfied.**
5. **Set R1 to R3, C1 to C3, and C_{VDD} so that the condition (R1 to R3) × (C1 to C3, C_{VDD}) ≥ 1×10^{-4} is satisfied.**
6. **Since the CO pin may become detection status transiently when the battery is being connected, connect the positive terminal of BAT1 last in order to prevent the three terminal protection fuse from cutoff.**

[For SCP, contact]
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Contact Us: http://www.dexerials.jp/en/

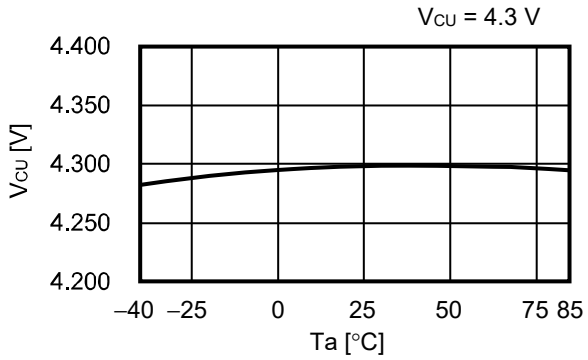
■ Precautions

- Do not connect batteries charged with $V_{CUn} + V_{HCn}$ or higher. If the connected batteries include a battery charged with $V_{CUn} + V_{HCn}$ or higher, the S-8215A series may become overcharge status after all pins are connected.
- In some application circuits, even if an overcharged battery is not included, the order of connecting batteries may be restricted to prevent transient output of CO detection pulses when the batteries are connected. Perform thorough evaluation with the actual application circuit.
- Before the battery connection, short-circuit the battery side pins R_{VDD} and R1, shown in the figure in "**■ Battery Protection IC Connection Examples**".
- The application conditions for the input voltage, output voltage, and load current should not exceed the package power dissipation.
- Do not apply to this IC an electrostatic discharge that exceeds the performance ratings of the built-in electrostatic protection circuit.
- ABLIC Inc. claims no responsibility for any disputes arising out of or in connection with any infringement of patents owned by a third party by products including this IC.

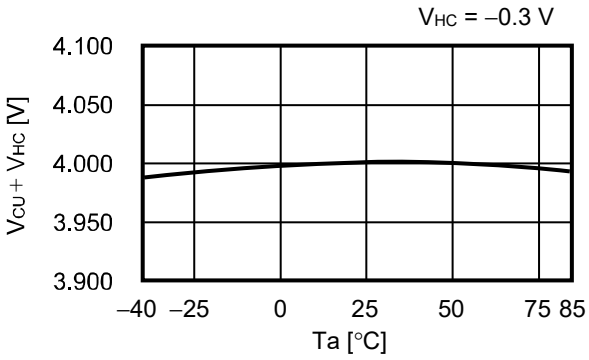
■ Characteristics (Typical Data)

1. Detection voltage

1. 1 V_{CU} vs. Ta

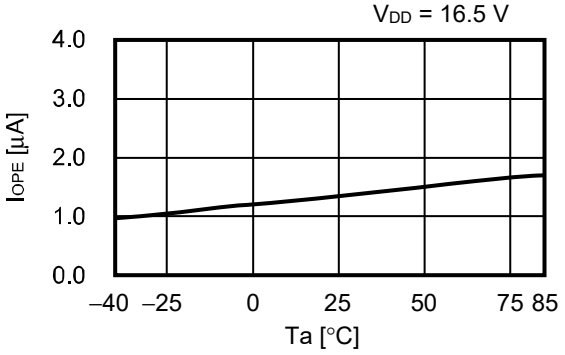


1. 2 V_{CU} + V_{HC} vs. Ta

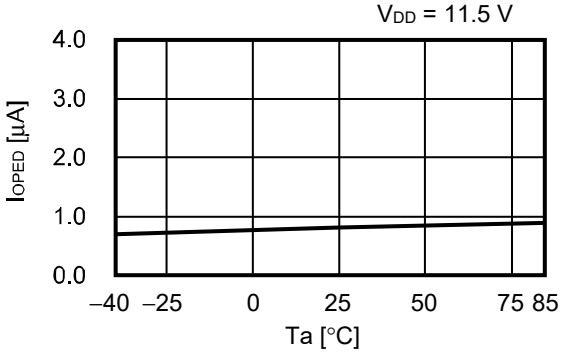


2. Current consumption

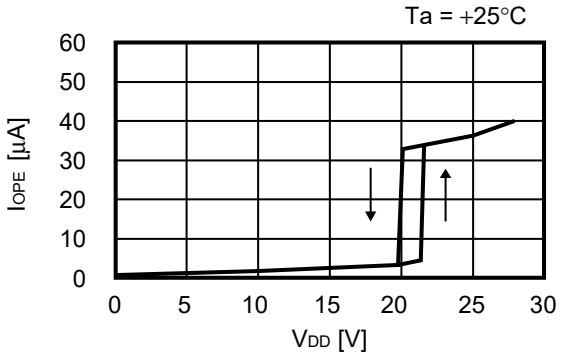
2. 1 I_{OPE} vs. Ta



2. 2 I_{OPED} vs. Ta

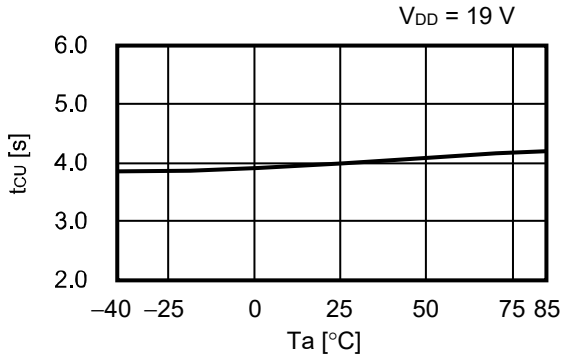


2. 3 I_{OPE} vs. V_{DD}



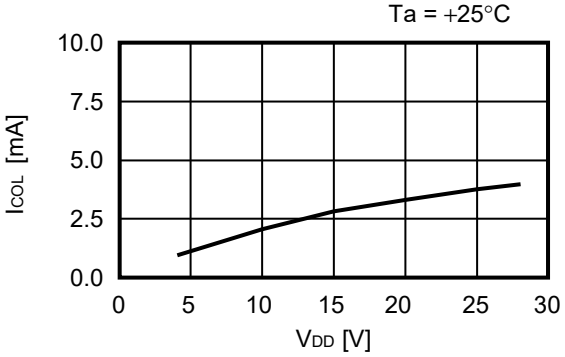
3. Delay time

3. 1 t_{CU} vs. Ta

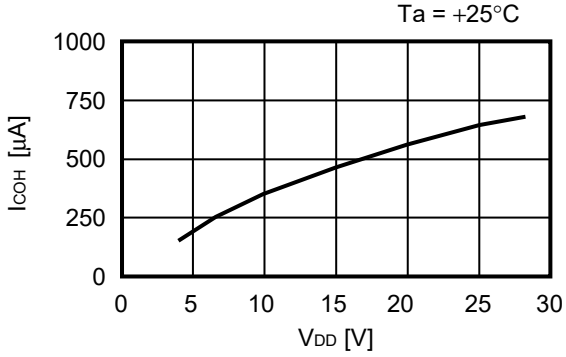


4. Output current

4. 1 I_{COL} vs. V_{DD}

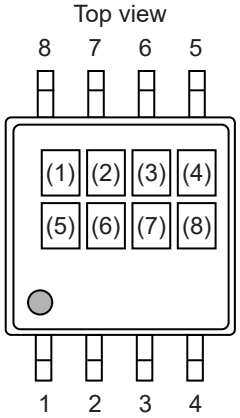


4. 2 I_{COH} vs. V_{DD}



■ Marking Specifications

1. TMSOP-8



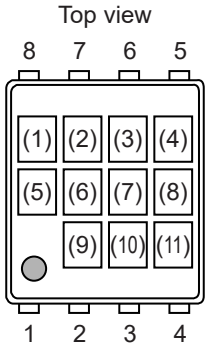
(1): Blank
(2) to (4): Product code (Refer to **Product name vs. Product code**)
(5): Blank
(6) to (8): Lot number

Product name vs. Product code

Product Name	Product Code		
	(2)	(3)	(4)
S-8215AAA-K8T2U	V	6	A
S-8215AAB-K8T2U	V	6	B
S-8215AAC-K8T2U	V	6	C
S-8215AAD-K8T2U	V	6	D
S-8215AAE-K8T2U	V	6	E
S-8215AAF-K8T2U	V	6	F
S-8215AAH-K8T2U	V	6	H
S-8215AAI-K8T2U	V	6	I
S-8215AAJ-K8T2U	V	6	J
S-8215AAK-K8T2U	V	6	K
S-8215AAL-K8T2U	V	6	L
S-8215AAM-K8T2U	V	6	M

Product Name	Product Code		
	(2)	(3)	(4)
S-8215AAN-K8T2U	V	6	N
S-8215AAO-K8T2U	V	6	O
S-8215AAP-K8T2U	V	6	P
S-8215AAQ-K8T2U	V	6	Q
S-8215AAR-K8T2U	V	6	R
S-8215AAS-K8T2U	V	6	S
S-8215AAT-K8T2U	V	6	T
S-8215AAU-K8T2U	V	6	U
S-8215AAV-K8T2U	V	6	V
S-8215AAW-K8T2U	V	6	W
S-8215AAX-K8T2U	V	6	X
S-8215AAY-K8T2U	V	6	Y
S-8215AAZ-K8T2U	V	6	Z

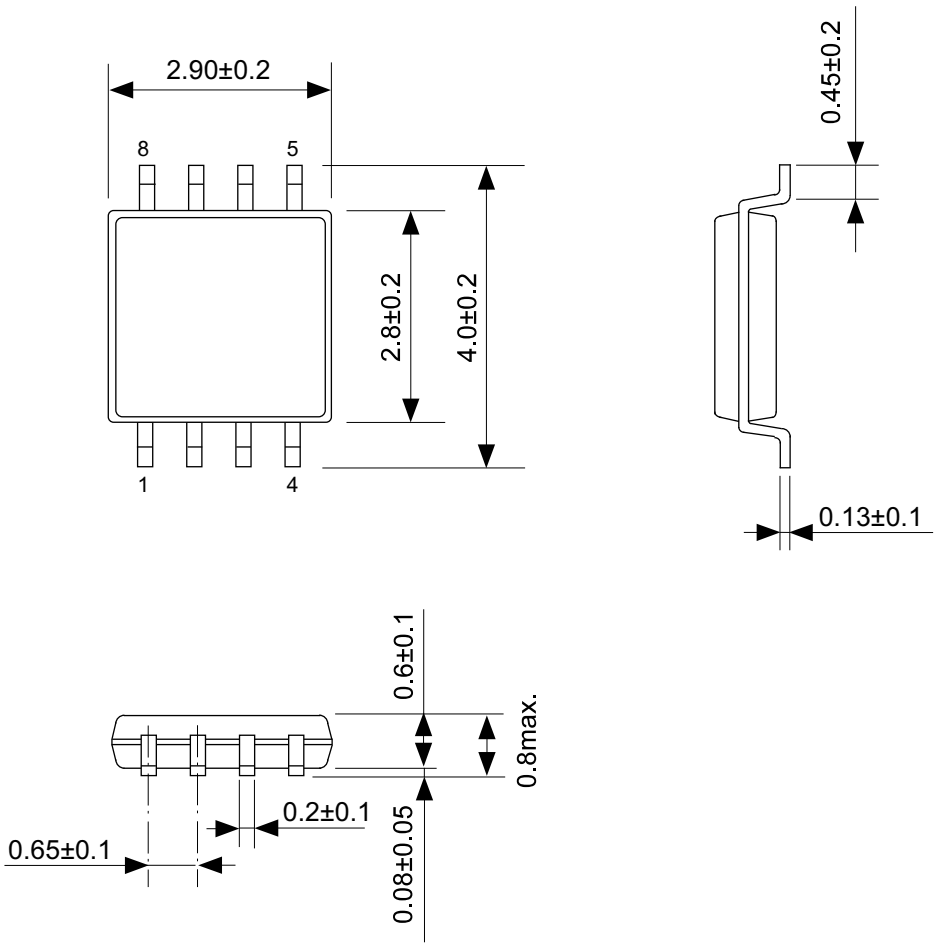
2. SNT-8A



(1): Blank
(2) to (4): Product code (Refer to **Product name vs. Product code**)
(5), (6): Blank
(7) to (11): Lot number

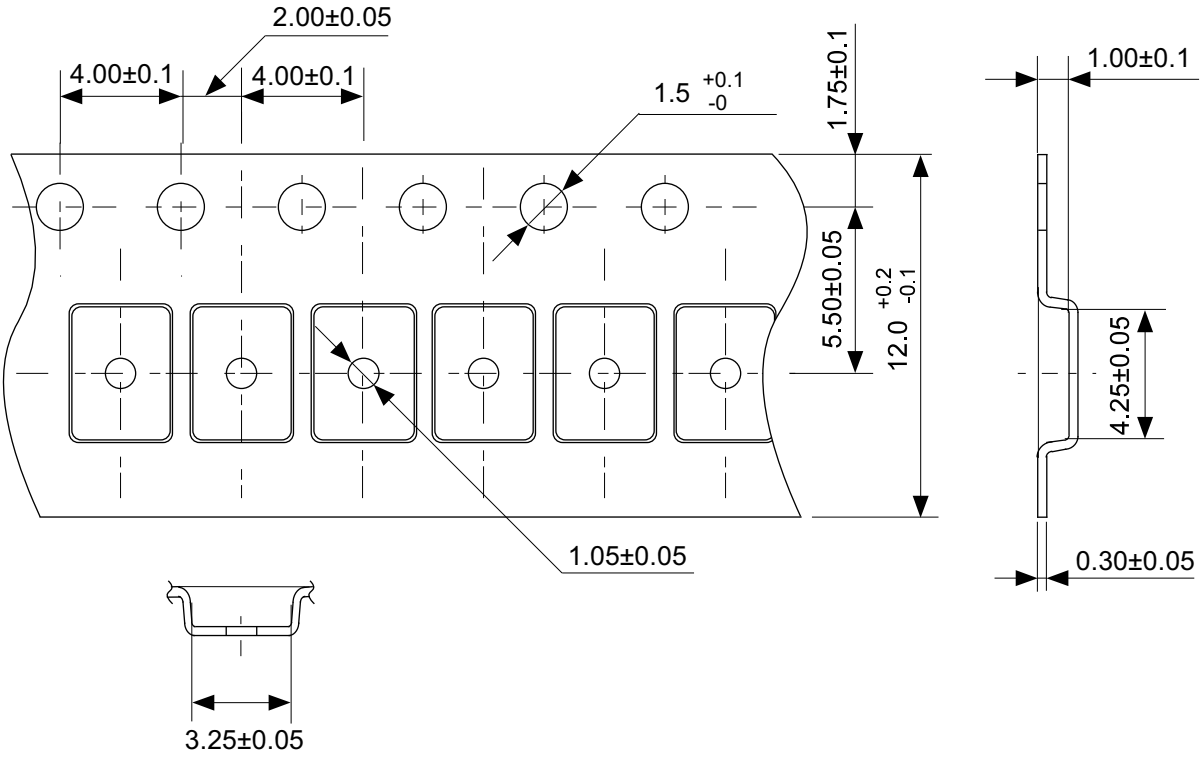
Product name vs. Product code

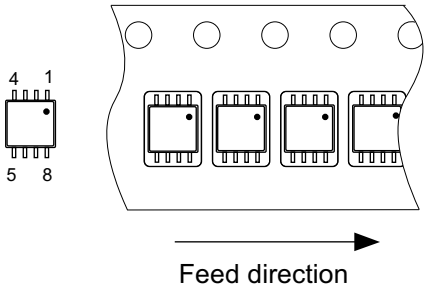
Product Name	Product Code		
	(2)	(3)	(4)
S-8215AAA-I8T1U	V	6	A
S-8215AAG-I8T1U	V	6	G
S-8215AAV-I8T1U	V	6	V



No. FM008-A-P-SD-1.2

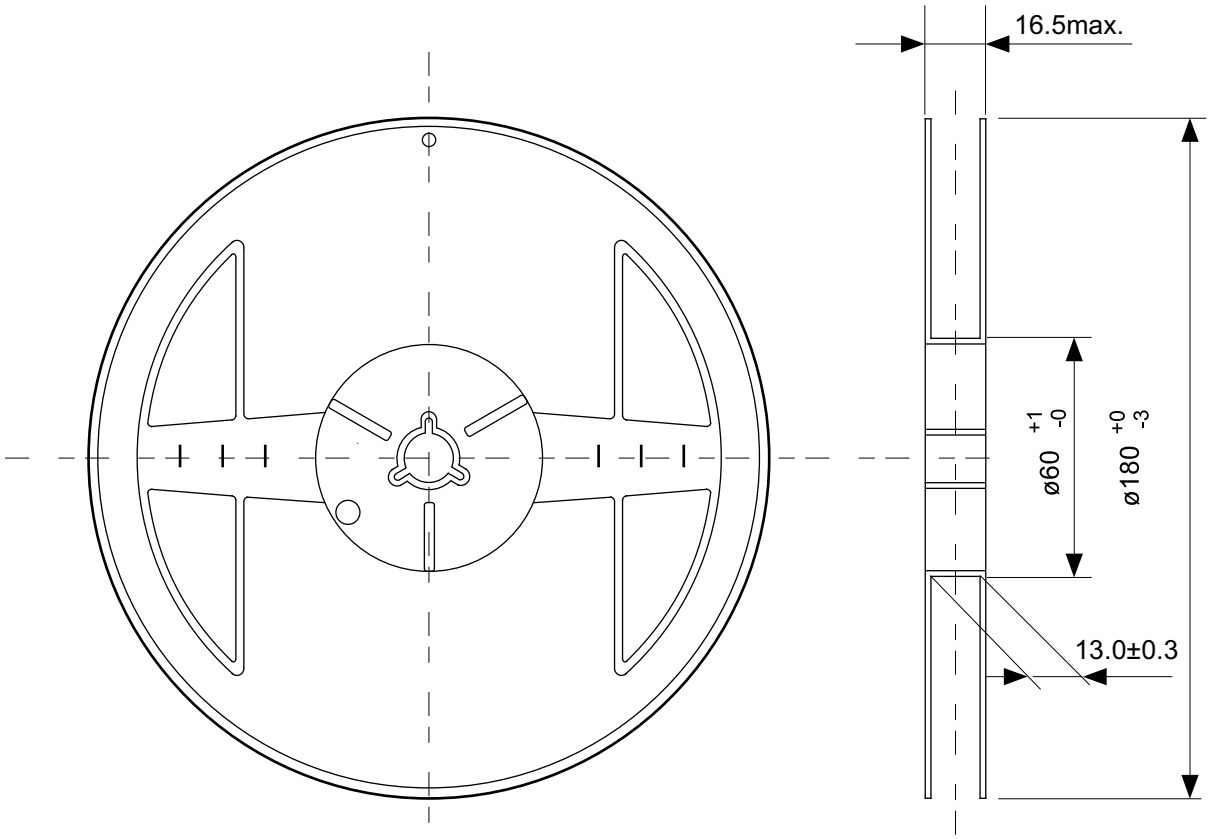
TITLE	TMSOP8-A-PKG Dimensions
No.	FM008-A-P-SD-1.2
ANGLE	
UNIT	mm
ABLIC Inc.	



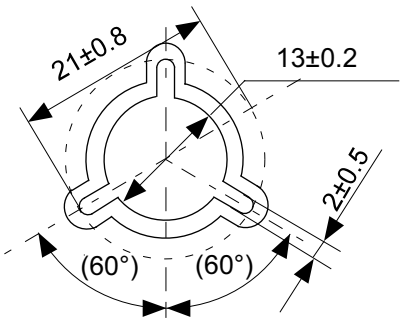


No. FM008-A-C-SD-2.0

TITLE	TMSOP8-A-Carrier Tape
No.	FM008-A-C-SD-2.0
ANGLE	
UNIT	mm
	ABLIC Inc.

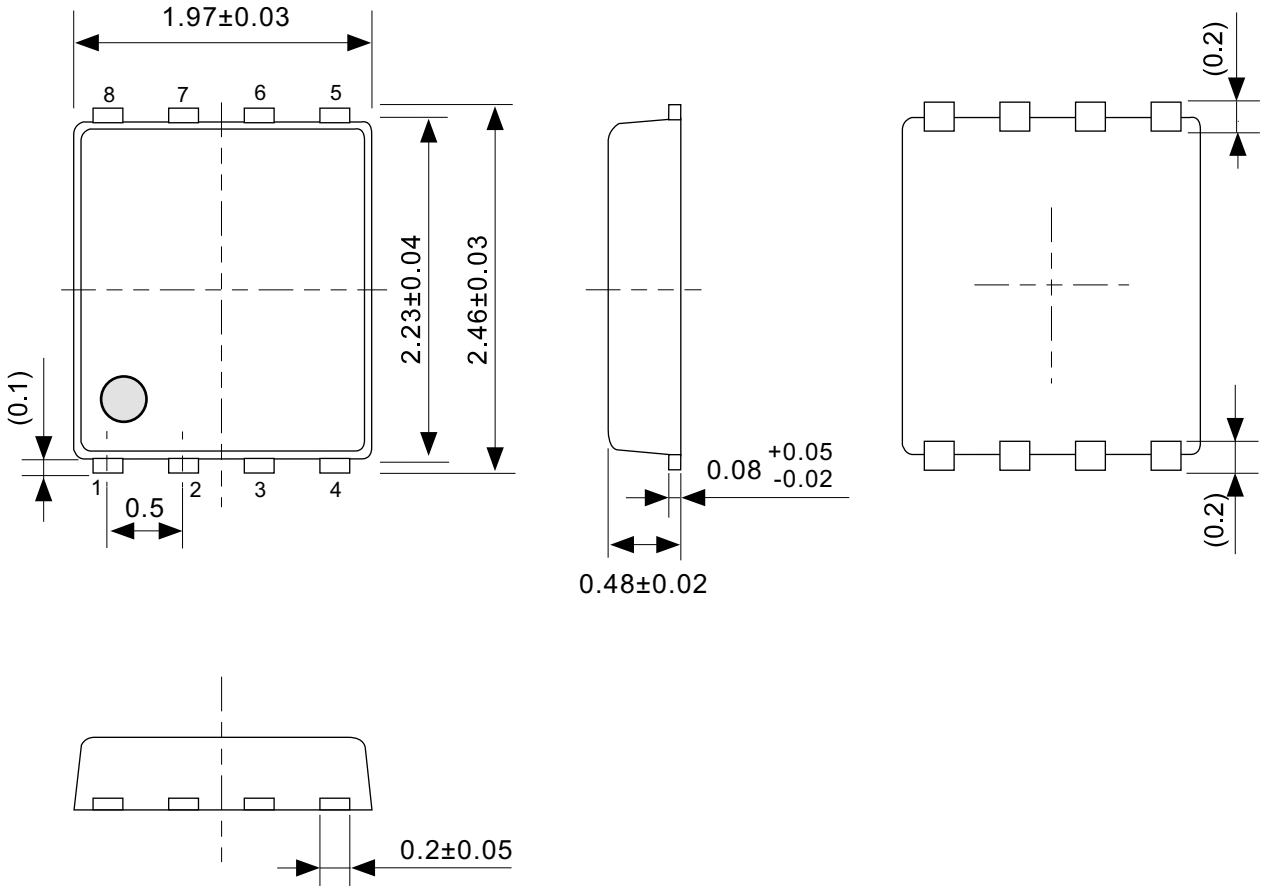


Enlarged drawing in the central part



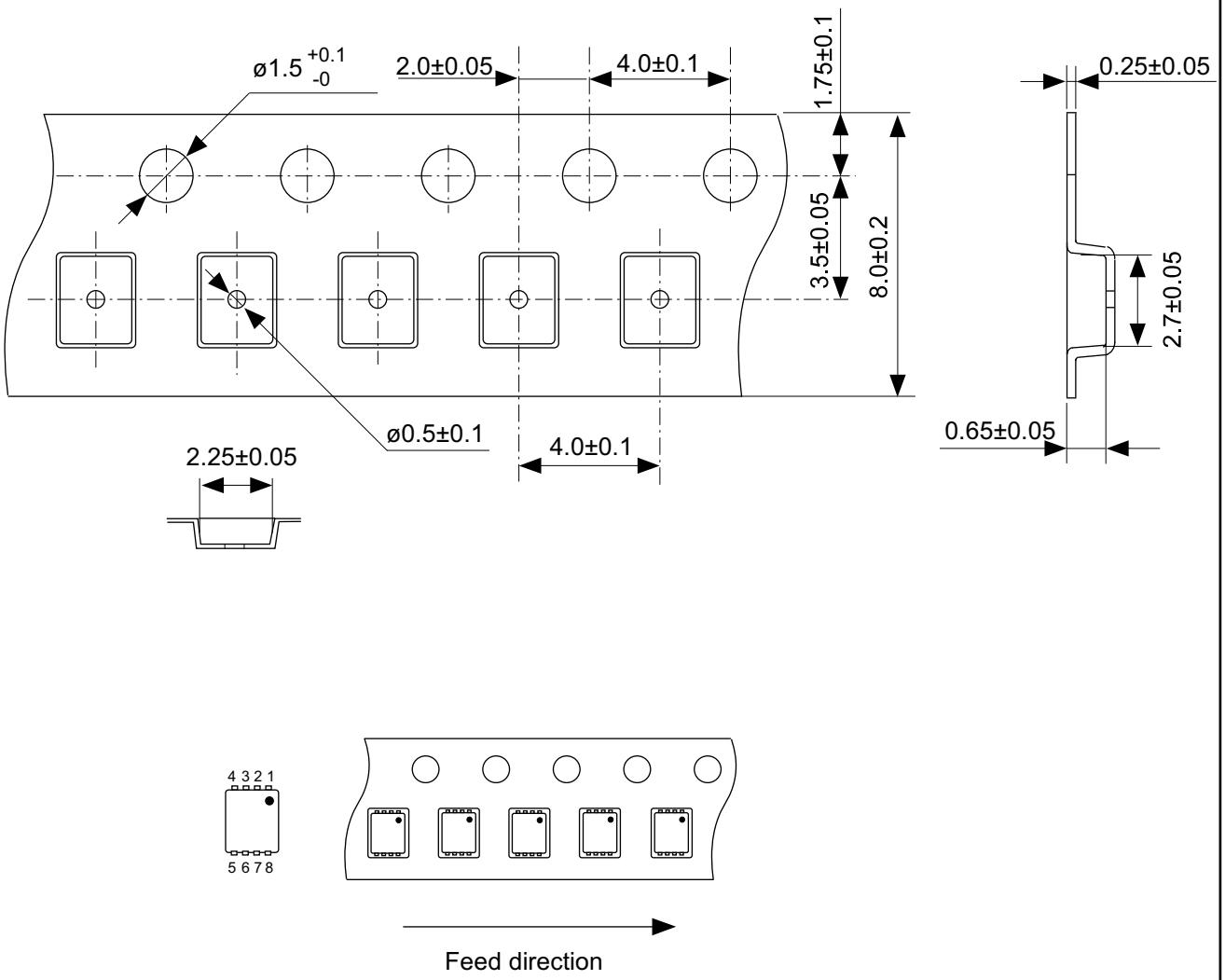
No. FM008-A-R-SD-1.0

TITLE	TMSOP8-A-Reel		
No.	FM008-A-R-SD-1.0		
ANGLE		QTY.	4,000
UNIT	mm		
ABLIC Inc.			



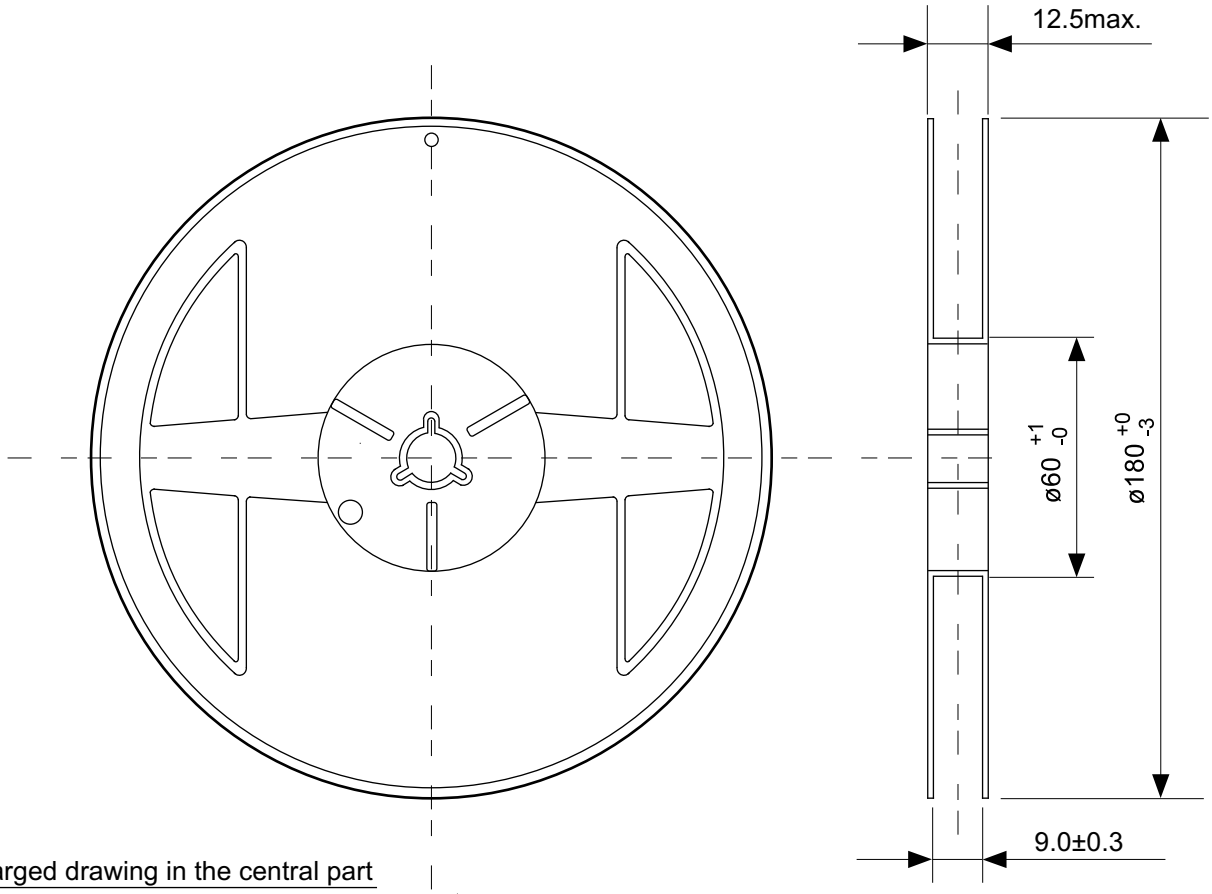
No. PH008-A-P-SD-2.1

TITLE	SNT-8A-A-PKG Dimensions
No.	PH008-A-P-SD-2.1
ANGLE	
UNIT	mm
ABLIC Inc.	

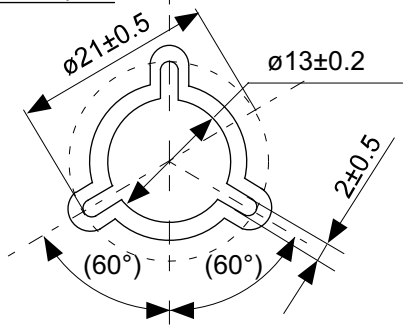


No. PH008-A-C-SD-2.0

TITLE	SNT-8A-A-Carrier Tape
No.	PH008-A-C-SD-2.0
ANGLE	
UNIT	mm
	ABLIC Inc.

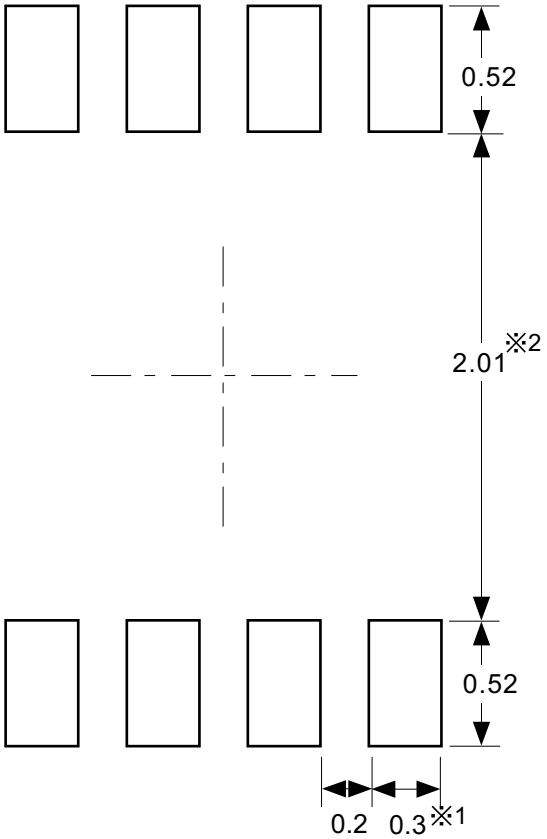


Enlarged drawing in the central part



No. PH008-A-R-SD-1.0

TITLE	SNT-8A-A-Reel		
No.	PH008-A-R-SD-1.0		
ANGLE		QTY.	5,000
UNIT	mm		
ABLIC Inc.			



※1. ランドパターンの幅に注意してください (0.25 mm min. / 0.30 mm typ.)。
※2. パッケージ中央にランドパターンを広げないでください (1.96 mm ~ 2.06 mm)。

注意 1. パッケージのモールド樹脂下にシルク印刷やハンダ印刷などしないでください。
2. パッケージ下の配線上のソルダーレジストなどの厚みをランドパターン表面から0.03 mm 以下にしてください。
3. マスク開口サイズと開口位置はランドパターンと合わせてください。
4. 詳細は〝SNTパッケージ活用の手引き〟を参照してください。

※1. Pay attention to the land pattern width (0.25 mm min. / 0.30 mm typ.).
※2. Do not widen the land pattern to the center of the package (1.96 mm to 2.06mm).

Caution 1. Do not do silkscreen printing and solder printing under the mold resin of the package.
2. The thickness of the solder resist on the wire pattern under the package should be 0.03 mm or less from the land pattern surface.
3. Match the mask aperture size and aperture position with the land pattern.
4. Refer to "SNT Package User's Guide" for details.

※1. 请注意焊盘模式的宽度 (0.25 mm min. / 0.30 mm typ.)。
※2. 请勿向封装中间扩展焊盘模式 (1.96 mm ~ 2.06 mm)。

注意 1. 请勿在树脂型封装的下面印刷丝网、焊锡。
2. 在封装下、布线上的阻焊膜厚度 (从焊盘模式表面起) 请控制在 0.03 mm 以下。
3. 钢网的开口尺寸和开口位置请与焊盘模式对齐。
4. 详细内容请参阅 "SNT 封装的应用指南"。

No. PH008-A-L-SD-4.1

TITLE	SNT-8A-A -Land Recommendation
No.	PH008-A-L-SD-4.1
ANGLE	
UNIT	mm
	ABLIC Inc.

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   The entire system in which the products are used must be sufficiently evaluated and judged whether the products are allowed to apply for the system on customer's own responsibility.
10. The products are not designed to be radiation-proof. The necessary radiation measures should be taken in the product design by the customer depending on the intended use.
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2.4-2019.07

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